

Notice of References Cited	Application/Control No. 09/834,649	Applicant(s)/Patent Under Reexamination MEYER ET AL.	
	Examiner Sharad K. Rampuria	Art Unit 2683	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0194990 A1	10-2003	Helferich, Richard J.	455/412.2
	B	US-6,470,181 B1	10-2002	Maxwell, Stewart Hodde	455/413
	C	US-2003/0032437 A1	02-2003	Bossemeyer et al.	455/466
	D	US-2002/0028665	03-2002	Mankovitz, Roy J.	455/186.1
	E	US-6,571,279 B1	05-2003	Herz et al.	709/217
	F	US-6,505,046 B1	01-2003	Baker, Steven F.	455/456.3
	G	US-2003/0027555 A1	02-2003	Malackowski et al.	455/414
	H	US-6,157,814 A	12-2000	Hymel et al.	340/7.56
	I	US-5,948,061 A	09-1999	Merriman et al.	709/219
	J	US-6,332,127 B1	12-2001	Bandera et al.	705/14
	K	US-6,091,956 A	07-2000	Hollenberg, Dennis D.	455/456.5
	L	US-6,278,449 B1	08-2001	Sugiarto et al.	715/826
	M	US-5,774,803 A	06-1998	Kariya, Kazuo	455/414.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.